

### Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	$I_D$
100V	78mΩ@10V	15A

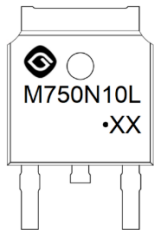
### Feature

- Trench Technology Power MOSFET
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Low Gate Resistance
- 100% UIS Tested
- 100%  $\Delta V_{DS}$  Tested

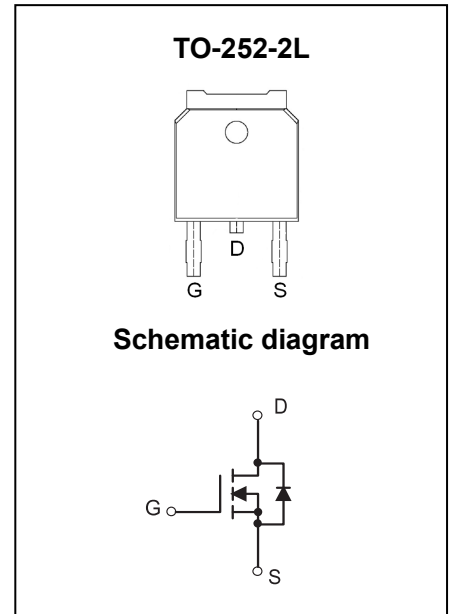
### Application

- Power Switching Application

### MARKING:



M750N10L = Device Code  
 XX = Date Code  
 Solid Dot = Green Indicator



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain - Source Voltage		$V_{DS}$	100	V
Gate - Source Voltage		$V_{GS}$	±20	V
Continuous Drain Current <sup>1</sup>	$T_C = 25^\circ\text{C}$	$I_D$	15	A
Continuous Drain Current <sup>1</sup>	$T_C = 100^\circ\text{C}$	$I_D$	10.5	A
Continuous Drain Current <sup>6</sup>	$T_A = 25^\circ\text{C}$	$I_D$	5	A
Pulsed Drain Current <sup>2</sup>		$I_{DM}$	45	A
Single Pulsed Avalanche Current <sup>3</sup>		$I_{AS}$	12.5	A
Single Pulsed Avalanche Energy <sup>3</sup>		$E_{AS}$	39	mJ
Power Dissipation <sup>5</sup>	$T_C = 25^\circ\text{C}$	$P_D$	37	W
Thermal Resistance from Junction to Ambient <sup>6</sup>		$R_{\theta JA}$	50	$^\circ\text{C/W}$
Thermal Resistance from Junction to Case		$R_{\theta JC}$	3.3	$^\circ\text{C/W}$
Junction Temperature		$T_J$	150	$^\circ\text{C}$
Storage Temperature		$T_{STG}$	-55~ +150	$^\circ\text{C}$

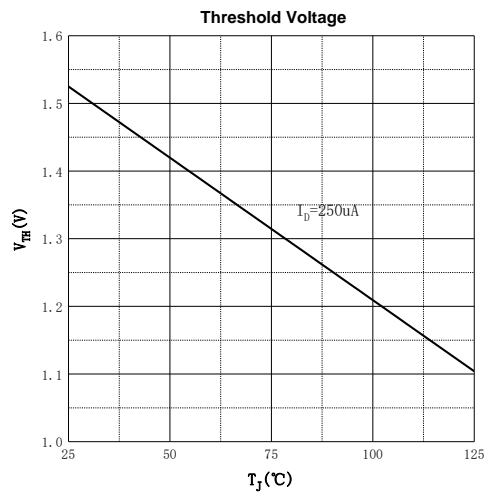
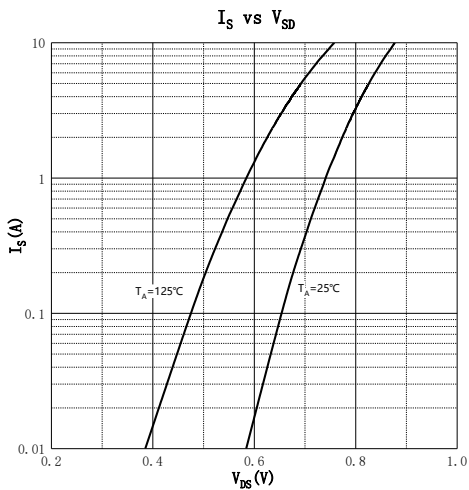
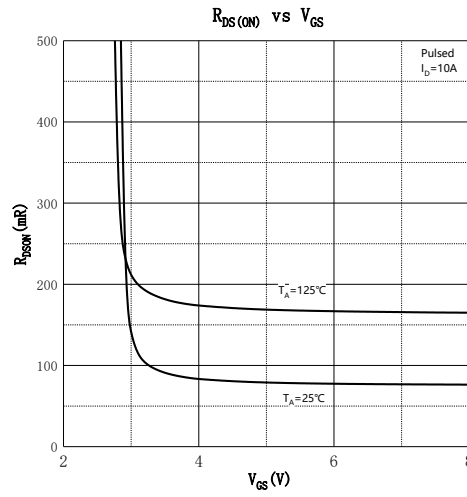
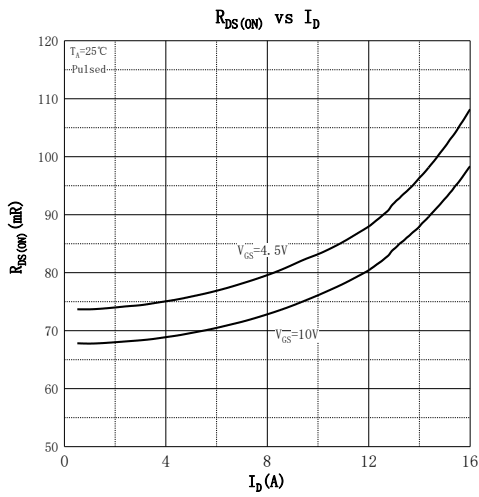
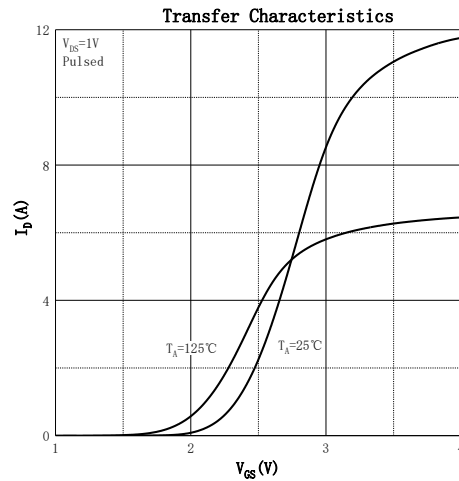
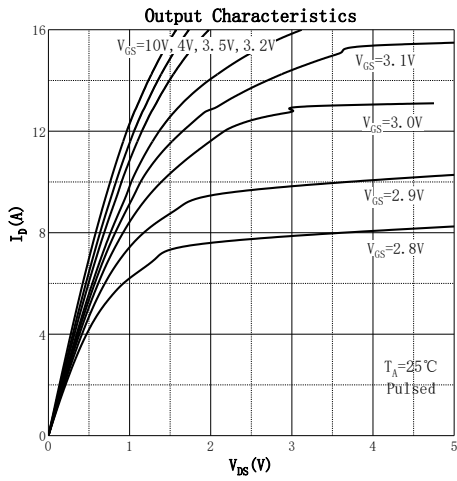
## MOSFET ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
<b>Off Characteristics</b>						
Drain - Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	100			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 100V, V_{GS} = 0V$			1	$\mu A$
Gate - Body Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
<b>On Characteristics<sup>4</sup></b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	1.5	2	V
Drain-source On-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 10A$		78	100	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5V, I_D = 10A$		16.5		S
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 45V, V_{GS} = 0V, f = 1MHz$		1029		pF
Output Capacitance	$C_{oss}$			32		
Reverse Transfer Capacitance	$C_{rss}$			30		
Gate Resistance	$R_g$	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$		1.5		$\Omega$
<b>Switching Characteristics</b>						
Total Gate Charge	$Q_g$	$V_{DS} = 45V, V_{GS} = 10V, I_D = 10A$		26.5		nC
Gate-source Charge	$Q_{gs}$			2.7		
Gate-drain Charge	$Q_{gd}$			6.7		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 45V, V_{GS} = 10V, R_L = 4.5\Omega$ $R_G = 3\Omega$		24		ns
Turn-on Rise Time	$t_r$			3.2		
Turn-off Delay Time	$t_{d(off)}$			6.5		
Turn-off Fall Time	$t_f$					
<b>Source - Drain Diode Characteristics</b>						
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	$V_{GS} = 0V, I_S = 10A$			1.2	V

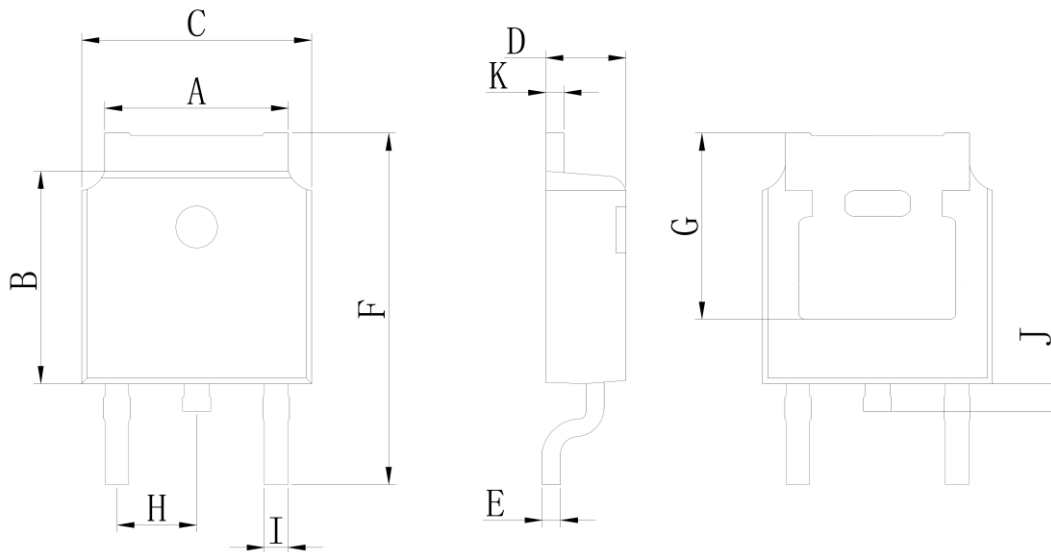
Notes :

- 1.The maximum current rating is limited by package.And device mounted on a large heatsink
- 2.Pulse Test : Pulse Width  $\leq 10\mu s$ , duty cycle  $\leq 1\%$ .
- 3.EAS condition:  $V_{DD} = 50V, V_{GS} = 10V, L = 0.5mH, R_G = 25\Omega$  Starting  $T_J = 25^\circ\text{C}$ .
- 4.Pulse Test : Pulse Width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
- 5.The power dissipation  $P_D$  is limited by  $T_{J(MAX)} = 150^\circ\text{C}$ .And device mounted on a large heatsink
- 6.Device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ .

**Typical Characteristics**



## TO-252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	5.050	5.650	0.199	0.222
B	5.800	6.400	0.228	0.252
C	6.250	6.850	0.246	0.270
D	2.200	2.400	0.087	0.094
E	0.400	0.600	0.016	0.024
F	9.710	10.310	0.382	0.406
G	5.050	5.650	0.199	0.222
H	2.100	2.500	0.083	0.098
I	0.700	0.900	0.028	0.035
J	0.500	0.700	0.020	0.028
K	0.400	0.600	0.016	0.024

单击下面可查看定价，库存，交付和生命周期等信息

[>>GP\(格瑞宝\)](#)